Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,248	NAKASHIMA ET AL.	
Examiner	Art Unit	
Alex Liew	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED						
Subclass	Date	Examiner				
						
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(INCLUDING SEARCH	DATE	EXMR
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382/103, 104, 107, 115, 118, 206, 236, 282, 299 limited to text search	7/22/2007	AL
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